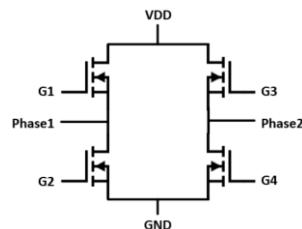
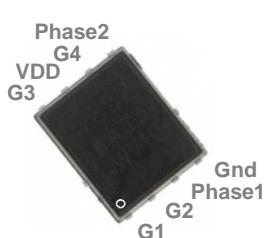


General Description

These Quad N-Channel enhancement mode power field effect transistors are using trench DMOS technology. This advanced technology has been especially tailored to minimize on-state resistance, provide superior switching performance, and withstand high energy pulse in the avalanche and commutation mode. These devices are well suited for high efficiency fast switching applications.

PPAK5x6 4 in 1 Pin Configuration



BVDSS	RDS(ON)	ID
65V	24mΩ	13.8A

Features

- 65V, 13.8A, RDS(ON) = 24mΩ@VGS = 10V
- Improved dv/dt capability
- Fast switching
- 100% EAS Guaranteed
- Green Device Available

Applications

- Full Bridge Applications
- Wireless charger Applications

Absolute Maximum Ratings $T_c=25^\circ\text{C}$ unless otherwise noted

Symbol	Parameter	Rating	Units
V_{DS}	Drain-Source Voltage	65	V
V_{GS}	Gate-Source Voltage	+20/-12	V
I_D	Drain Current – Continuous ($T_c=25^\circ\text{C}$)	13.8	A
	Drain Current – Continuous ($T_c=100^\circ\text{C}$)	8.7	A
I_{DM}	Drain Current – Pulsed ¹	55.2	A
EAS	Single Pulse Avalanche Energy ²	9.1	mJ
IAS	Single Pulse Avalanche Current ²	13.5	A
P_D	Power Dissipation ($T_c=25^\circ\text{C}$)	13.6	W
	Power Dissipation – Derate above 25°C	0.109	W/°C
T_{STG}	Storage Temperature Range	-55 to 150	°C
T_J	Operating Junction Temperature Range	-55 to 150	°C

Thermal Characteristics

Symbol	Parameter	Typ.	Max.	Unit
$R_{\theta JA}$	Thermal Resistance Junction to ambient	---	62	°C/W
$R_{\theta JC}$	Thermal Resistance Junction to Case	---	9.2	°C/W

Electrical Characteristics ($T_J=25^\circ\text{C}$, unless otherwise noted)
Static State Characteristics

Symbol	Parameter	Conditions	Min.	Typ.	Max.	Unit
BV_{DSS}	Drain-Source Breakdown Voltage	$\text{V}_{\text{GS}}=0\text{V}$, $\text{I}_D=250\mu\text{A}$	65	---	---	V
$\Delta \text{BV}_{\text{DSS}}/\Delta T_J$	BV_{DSS} Temperature Coefficient	Reference to 25°C , $\text{I}_D=1\text{mA}$	---	0.03	---	$^\circ\text{C}$
I_{DSS}	Drain-Source Leakage Current	$\text{V}_{\text{DS}}=60\text{V}$, $\text{V}_{\text{GS}}=0\text{V}$, $T_J=25^\circ\text{C}$	---	---	1	μA
		$\text{V}_{\text{DS}}=48\text{V}$, $\text{V}_{\text{GS}}=0\text{V}$, $T_J=85^\circ\text{C}$	---	---	10	μA
I_{GSS}	Gate-Source Leakage Current	$\text{V}_{\text{GS}}=+20\text{V}$, $\text{V}_{\text{DS}}=0\text{V}$	---	---	100	nA
$\text{R}_{\text{DS(ON)}}$	Static Drain-Source On-Resistance ³	$\text{V}_{\text{GS}}=10\text{V}$, $\text{I}_D=3\text{A}$	---	20	24	$\text{m}\Omega$
		$\text{V}_{\text{GS}}=4.5\text{V}$, $\text{I}_D=2\text{A}$	---	30	38	$\text{m}\Omega$
$\text{V}_{\text{GS(th)}}$	Gate Threshold Voltage	$\text{V}_{\text{GS}}=\text{V}_{\text{DS}}$, $\text{I}_D=250\mu\text{A}$	1	1.6	2.5	V
$\Delta \text{V}_{\text{GS(th)}}$	$\text{V}_{\text{GS(th)}}$ Temperature Coefficient		---	-5.1	---	$\text{mV}/^\circ\text{C}$
g_{fs}	Forward Transconductance	$\text{V}_{\text{DS}}=10\text{V}$, $\text{I}_D=3\text{A}$	---	3	---	S

Dynamic Characteristics

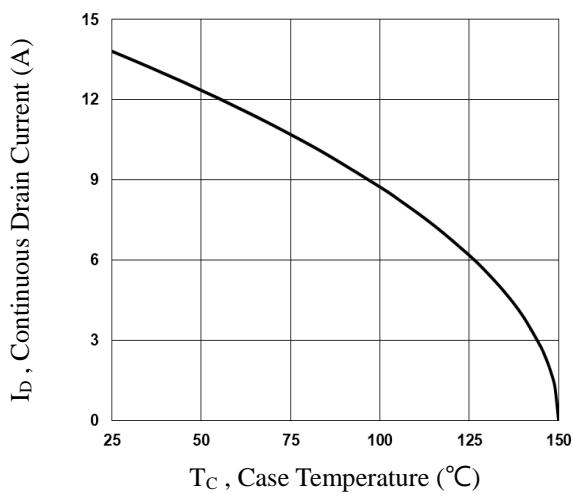
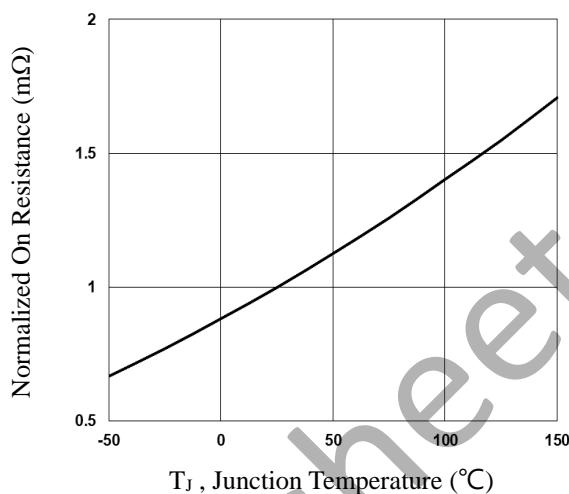
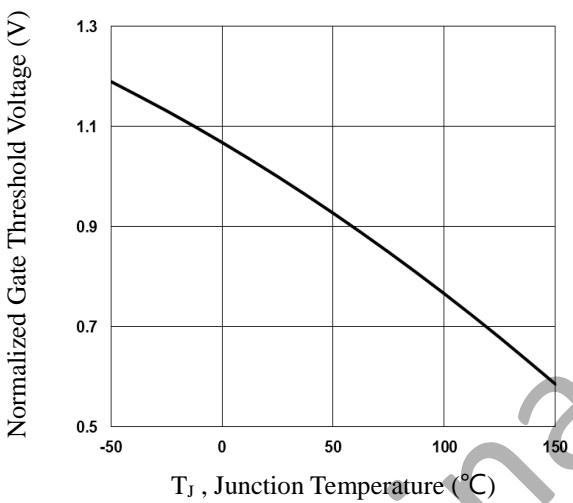
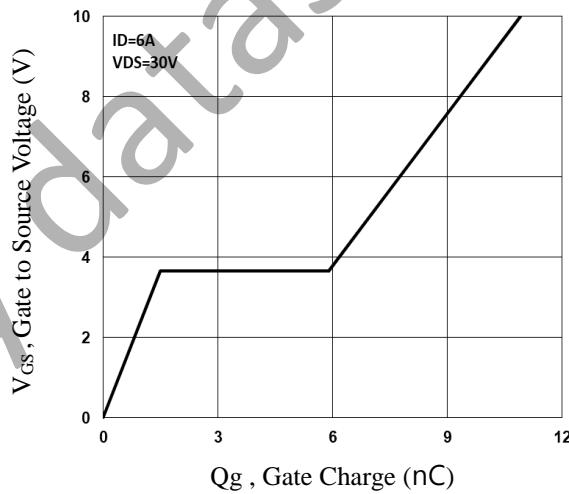
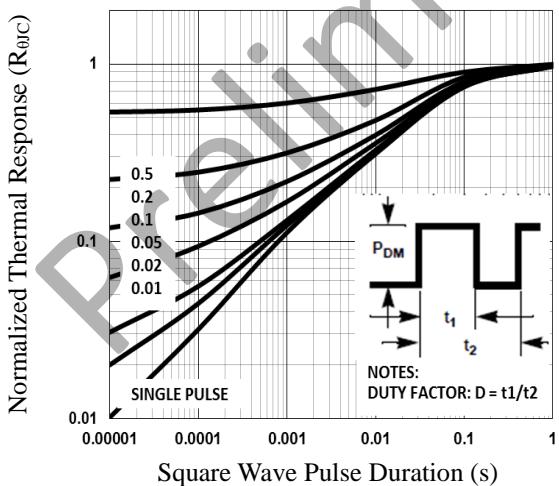
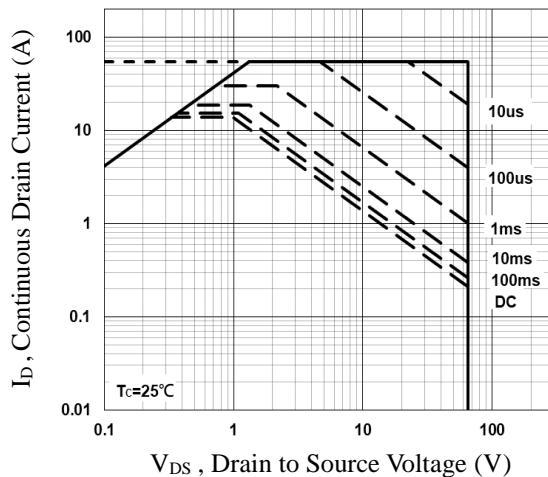
Q_g	Total Gate Charge ^{3, 4}	$\text{V}_{\text{DS}}=30\text{V}$, $\text{V}_{\text{GS}}=10\text{V}$, $\text{I}_D=6\text{A}$	---	10.9	22	nC
Q_{gs}	Gate-Source Charge ^{3, 4}		---	1.5	3	
Q_{gd}	Gate-Drain Charge ^{3, 4}		---	4.4	9	
$\text{T}_{\text{d(on)}}$	Turn-On Delay Time ^{3, 4}	$\text{V}_{\text{DD}}=30\text{V}$, $\text{V}_{\text{GS}}=10\text{V}$, $\text{R}_G=3.3\Omega$ $\text{I}_D=1\text{A}$	---	8	16	ns
T_r	Rise Time ^{3, 4}		---	12	24	
$\text{T}_{\text{d(off)}}$	Turn-Off Delay Time ^{3, 4}		---	25	50	
T_f	Fall Time ^{3, 4}		---	18	36	
C_{iss}	Input Capacitance	$\text{V}_{\text{DS}}=30\text{V}$, $\text{V}_{\text{GS}}=0\text{V}$, $\text{F}=1\text{MHz}$	---	653	1300	pF
C_{oss}	Output Capacitance		---	192	380	
C_{rss}	Reverse Transfer Capacitance		---	27	60	
R_g	Gate resistance	$\text{V}_{\text{GS}}=0\text{V}$, $\text{V}_{\text{DS}}=0\text{V}$, $\text{F}=1\text{MHz}$	---	0.3	---	Ω

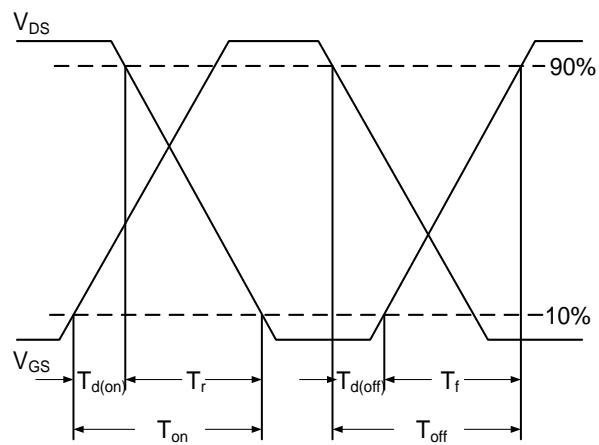
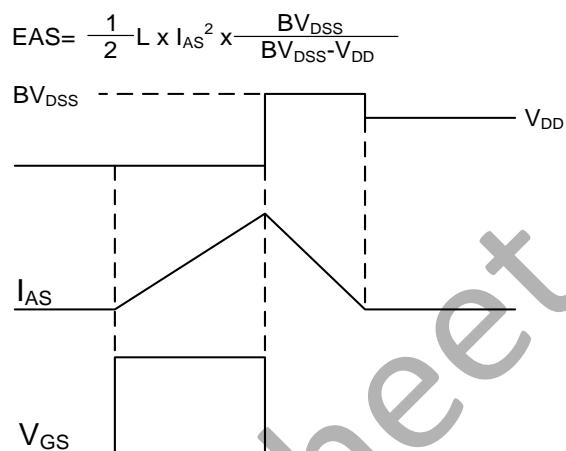
Drain-Source Diode Characteristics

Symbol	Parameter	Conditions	Min.	Typ.	Max.	Unit
I_s	Continuous Source Current	$\text{V}_G=\text{V}_D=0\text{V}$, Force Current	---	---	13.8	A
I_{SM}	Pulsed Source Current ³		---	---	27.6	A
V_{SD}	Diode Forward Voltage ³	$\text{V}_{\text{GS}}=0\text{V}$, $\text{I}_s=1\text{A}$, $T_J=25^\circ\text{C}$	---	---	1	V

Note :

1. Repetitive Rating : Pulsed width limited by maximum junction temperature.
2. $\text{V}_{\text{DD}}=50\text{V}$, $\text{V}_{\text{GS}}=10\text{V}$, $L=0.1\text{mH}$, $\text{I}_{\text{AS}}=13.5\text{A}$, $\text{R}_G=25\Omega$, Starting $T_J=25^\circ\text{C}$.
3. The data tested by pulsed , pulse width $\leq 300\text{us}$, duty cycle $\leq 2\%$.
4. Essentially independent of operating temperature.


Fig.1 Continuous Drain Current vs. TC

Fig.2 Normalized RDS(on) vs. TJ

Fig.3 Normalized V_{th} vs. TJ

Fig.4 Gate Charge Waveform

Fig.5 Normalized Transient Impedance

Fig.6 Maximum Safe Operation Area


Fig.7 Switching Time Waveform

Fig.8 EAS Waveform

Preliminary datasheet

PPAK5x6 4 in 1 PACKAGE INFORMATION

